

Notice of References Cited	Application/Control No. 10/535,740		Applicant(s)/Patent Under Reexamination HECKEL ET AL.	
	Examiner Adi Amrany		Art Unit 2836	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,777,912	08-2004	Yamada et al.	320/118
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NON-PATENT DOCUMENTS

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